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Measurements for Remote Identification of Electrical Equipment

Specialists' Meeting on Remote Intelligence of Building Interiors

QINETIQ/17/01715





Thomas Badran 8th May 2017

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1. Introduction



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Introduction



- Modern electrical equipment, even if tested for electromagnetic compatibility (EMC), still unintentionally injects signals onto the mains electricity supply
- EMC testing looks at peak magnitude of these signals
 - Ensures that they stay below allowed thresholds
 - Not concerned with other characteristics of the signal
- Inductive loads produce a noticeable impact on the mains signal
- Switched mode power supplies will also induce a measureable harmonic signal
- Particular makes or items of equipment may produce unique detectable signals

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2.1 Experimental Approach

Spectral Signatures



SECURITY CLASSIFICATION – UNCLASSIFIED

Measuring Spectral Signatures

- Rohde & Schwarz ESR7 EMI Test Receiver and controller PC
- Mains filtered by LISN (Line Impedance Stabilisation Network) device
 - Recorded signal is unique to the device(s) being tested, with no noise injected from other devices in the building
 - Provides about 100 dB of filtering, and an additional 40 dB is provided by spectral analyser

• Records in 2 passes:

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- 9 to 150 kHz at 200 Hz bandwidth
- 150 kHz to 3 MHz at 9 kHz bandwidth
- 10 second integration time for each pass

• EMC test houses typically look at maxima of peaks

- We also recorded average spectra over integration time





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2.2 Experimental Approach

Current Transients



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Measuring Current Transients

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- Uses a Newtons 4th Power Analyzer (PPA5531)
- Current measured at 20 ms resolution
 - Occasionally sample rate changes to 30 & 40 ms
- Transient signals were recorded with and without the LISN
 - No significant noise was observed in the absence of the LISN

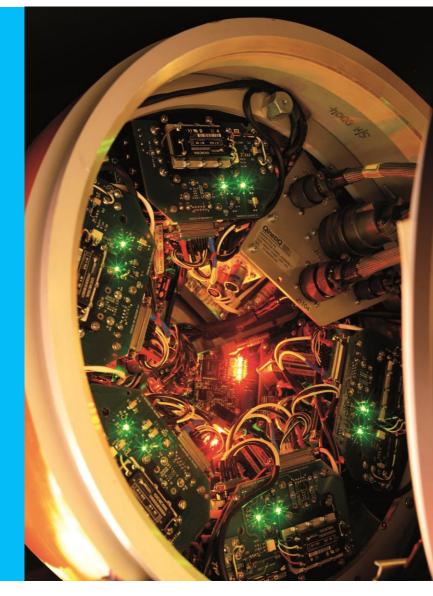








Device Identification from Spectra



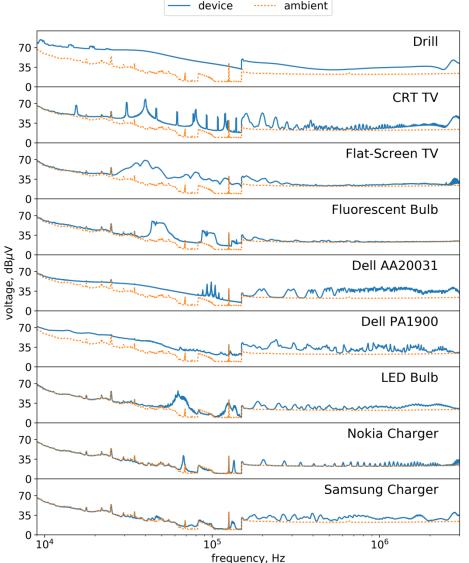
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Device Identification from Spectra Classifying individual Devices



Visually distinctive device signatures

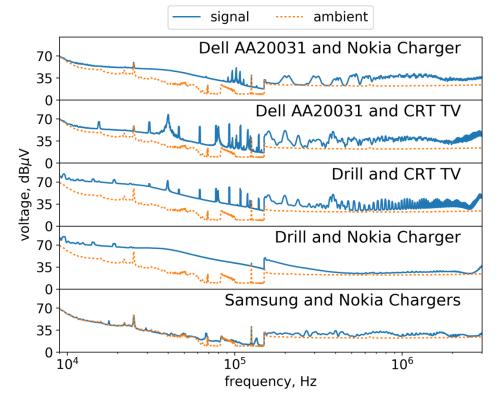
- I could easily tell which device was being measured from its spectra in the lab
- Multiple measurements of the same device at different times gave near identical spectra
 - Signal above 2 MHz less stable
- Ambient also has clear peaks
 - Some of these are easily associated with radio broadcasts



device

Device Identification from Spectra Identifying Devices in Combination

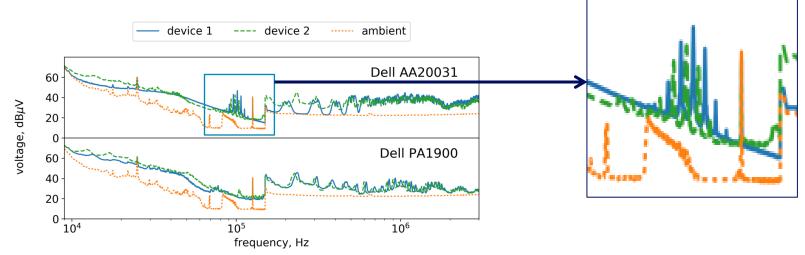
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- When measuring for multiple devices running at the same time there are generally clear features from both
- Exception is when running the drill with a low power device (Nokia phone charger), and the signal from the drill dominates the features from the phone charger

Device Identification from Spectra Nominally Identical Devices

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• The spectra for nominally identical devices are overall similar

There appears to be a constant shift in both axes

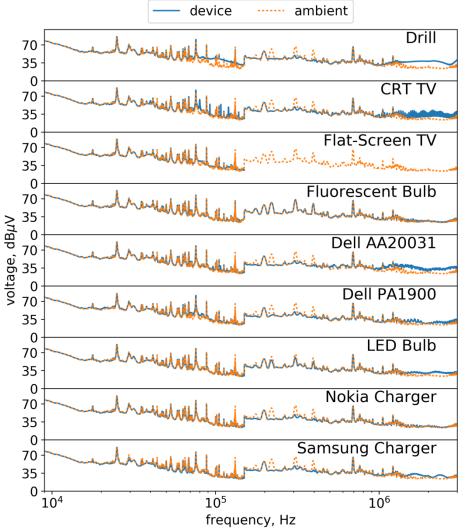
 Assumed to be due to manufacturing tolerances of various capacitors in the switch mode power supply

• May be enough to identify a specific instance of a device in the presence of other intelligence information

Device Identification from Spectra Unfiltered Mains Signal



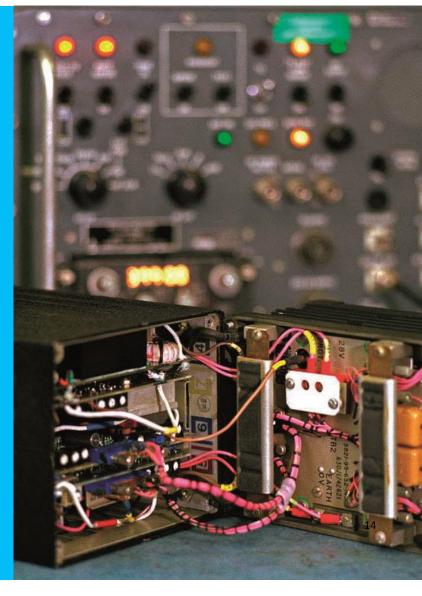
- Lack of any filtering of the background mains signal
 - N.b. this was at an EMC testing facility including multiple test chambers and 2 floors of office equipment
- Some features of the high powered devices are visible
- How much filtering would be needed for measuring these signals in a typical house?





3.2 Results

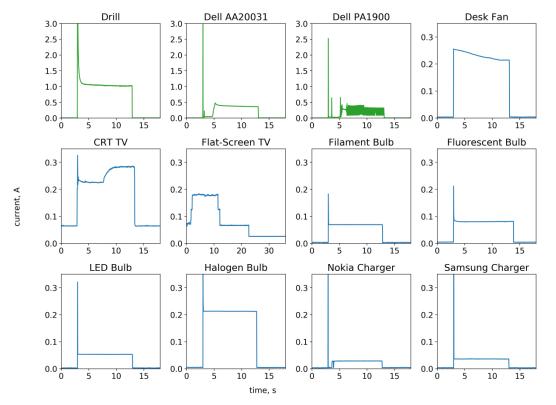
Device identification from Current Transients



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Device Identification from Current Transients





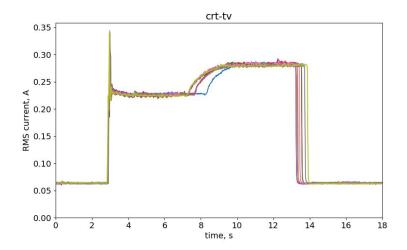
• In general there is a pattern of in-rush current followed by a steady state

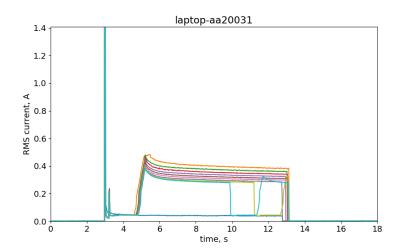
Simple devices have similar transients

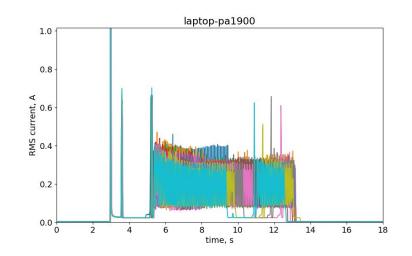
- More complex devices show more obvious features
- Both the TV's also draw a measurable standby current

Device Identification from Current Transients









- Transient features are consistent across different test runs
- The PA-1900 laptop power supply has a particularly noisy transient signal



4. Conclusions



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Conclusions



- A range of common household electrical devices can be identified from the power density spectrum of the voltage they superimpose onto the mains
- Some devices are readily identifiable when passively measuring these signals
- Particular instances of the device appear to be separable
- Current transient signals could provide useful pattern of life information

Future Work



• Apply machine learning techniques to classify devices

- Initial experimentation with the raw data and no feature extraction shows promise
- Expert knowledge could be used to identify important features, and provide manually defined features for higher discrimination capability

• Typical levels of background noise expected in the field are not known

- How much filtering would be required to apply this work in the field?

• Spectral feature changes over time could be used as another discriminator

- Would require short integration times





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